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F. M. Stumpf

J. P. Verhalen

February 27, 1967

Critical Analysis of Letter dated February 7th From
California Division of Industrial Safety

Please review carefully, the letter sent to the Association and,
by memorandum explain the difference between the "standard light field
technique" and "dark field microscopes with phase contrast".

Do you recommend a reply and, if so, what are your suggestions?

JPV/dso

cc: J. F. O'Rourke

